Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/710,828	EDELSTEIN ET AL.
Examiner	Art Unit
Marcos D. Pizarro-Crespo	2814

SEARCHED			
Class	Subclass	Date	Examiner
257	750-766	3/2/2007	MDP
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH	TES STRATEGY)
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